Searched



Application/Control No.

Applicant(s)/Patent Under Reexamination

10668010

SINHA ET AL.

Examiner

Kaplan, Hal I

2836

Art Unit

Class	SubClass	Date		Examiner
307	651	10/11/2006	НК	
374	172	10/11/2006	HK	
374	176	10/11/2006	HK	
702	99	10/11/2006	HK	
365	211	10/11/2006	HK	

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- [U.S. Patent and Trademark Office	Part of Paper No.: 20061011
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Search Notes



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. Notes	Date		Examiner
374/1,170,172,176,178 (consulted Gail Verbitsky)	02/14/2006	HK	
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365/211,222 (consulted Amir Zarabian)	10/11/2006	НК	
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	10/11/2006	HK	
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Interference Searched



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